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| Notice of References Cited | Application/Control No. 10/821,056 | Applicant(s)/Patent Under Reexamination JENSEN, HENRIK T. | |
| | Examiner Khai M. Nguyen | Art Unit 2819 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------------|----------------|
| * | A | US-6,512,468 | 01-2003 | Zhong, Eric | 341/61 |
| * | B | US-6,473,475 | 10-2002 | Putzeys, Bruno J. G. | 375/350 |
| * | C | US-5,119,093 | 06-1992 | Vogt et al. | 341/123 |
| * | D | US-5,398,029 | 03-1995 | Toyama et al. | 341/61 |
| * | E | US-5,903,482 | 05-1999 | Iwamura et al. | 708/313 |
| * | F | US-6,061,704 | 05-2000 | Ostman et al. | 708/313 |
| * | G | US-5,446,398 | 08-1995 | Iwata, Toshio | 327/113 |
| * | H | US-5,621,404 | 04-1997 | Heiss et al. | 341/61 |
| * | I | US-6,462,682 | 10-2002 | Hellberg, Richard | 341/61 |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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